

<b>Notice of References Cited</b>	Application/Control No. 10/644,048		Applicant(s)/Patent Under Reexamination HYDE ET AL.	
	Examiner Eric B. Kiss		Art Unit 2192	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0046029 A1	03-2003	Wiener et al.	702/186
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	William Aldrich, "Using Model Coverage Analysis to Improve the Controls Development Process," AIAA Modeling and Simulation Technologies Conference and Exhibit, August 2002, Monterey, California, 11 pages.
	V	"MATLAB digest," vol. 10, no. 4, July 2002 [online], accessed 09/16/2005, Retrieved from Internet <URL: <a href="http://www.mathworks.com/company/newsletters/digest/july02">http://www.mathworks.com/company/newsletters/digest/july02</a> >, 2 pages.
	W	Usha Santhanam, "Automating Software Module Testing for FAA Certification," ACM, Proceedings of the 2001 annual ACM SIGAda international conference on Ada, 2001, pp. 31-38.
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.